Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/740,615	SCHULTZ ET AL.	
Examiner	Art Unit	
Ann Y. Lam	1641	

SEARCHED					
Class	Subclass	Date	Examiner		
436	577 121 121 13	2/2967	00		
1	524 525 804				
356	34)				
422	8304 (31)				
435	80 8 muthal 80	2	4		
polak	alto 80	64			
	······································				

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

		Y)
	DATE	EXMR
east	9/29/07	Re